




RADIO TEST REPORT


Test Report No. : 32BE0281-HO-01-A-R2

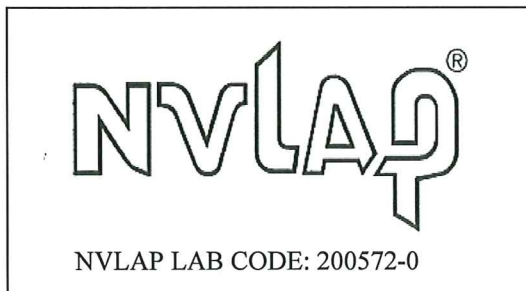
Applicant : DENSO CORPORATION
Type of Equipment : Remote Keyless Entry System (Transmitter)
Model No. : 12BDP
Test regulation : FCC Part 15 Subpart C: 2012
FCC ID : HYQ12BDP
Test Result : Complied

1. This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.
2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with above regulation.
4. The test results in this report are traceable to the national or international standards.
5. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.
6. This report is a revised version of 32BE0281-HO-01-A-R1. 32BE0281-HO-01-A-R1 is replaced with this report.

Date of test: October 20, 2011

Representative test engineer: 
Takeshi Choda
Engineer of WiSE Japan,
UL Verification Service

Approved by: 
Shinya Watanabe
Leader of WiSE Japan,
UL Verification Service



This laboratory is accredited by the NVLAP LAB CODE 200572-0, U.S.A. The tests reported herein have been performed in accordance with its terms of accreditation. *As for the range of Accreditation in NVLAP, you may refer to the WEB address, <http://www.ul.com/japan/jpn/pages/services/emc/about/mark1/index.jsp#nvlap>

CONTENTS **PAGE**

SECTION 1: Customer information 3
SECTION 2: Equipment under test (E.U.T.)..... 3
SECTION 3: Test specification, procedures & results..... 4
SECTION 4: Operation of E.U.T. during testing..... 7
SECTION 5: Radiated emission (Electric Field Strength of Fundamental and Spurious Emission) 8
SECTION 6: Automatically deactivate 9
SECTION 7: -20dB and 99% Occupied Bandwidth 9
APPENDIX 1: Data of EMI test 10
 Automatically deactivate.....10
 Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)..... 11
 -20dB and 99% Occupied Bandwidth.....12
 Duty Cycle13
APPENDIX 2: Test Instruments..... 15
APPENDIX 3: Photographs of test setup..... 16
 Radiated emission16
 Worst case position17

SECTION 1: Customer information

Company Name : DENSO CORPORATION
Address : 1-1 Showa-cho, Kariya-shi, Aichi-ken, 448-8661 Japan
Telephone Number : +81-566-61-7252
Facsimile Number : +81-566-25-4837
Contact Person : HIROMICHI HANAI

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : Remote Keyless Entry System (Transmitter)
Model No. : 12BDP
Serial No. : Refer to Clause 4.2
Rating : DC3.0V
Receipt Date of Sample : October 13, 2011
Country of Mass-production : Japan, China, and United States of America
Condition of EUT : Engineering prototype
(Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT : No Modification by the test lab

2.2 Product Description

General Specification

Clock frequency(ies) in the system : 8MHz

Radio Specification

Radio Type : Transmitter
Frequency of Operation : 314.35 MHz
Modulation : ASK (A1D)
Power Supply (radio part input) : DC 3.0V
Antenna type : Built-in type (Fixed)

UL Japan, Inc.

Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

Facsimile : +81 596 24 8124

SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : Test specification: FCC Part 15 Subpart C: 2012, final revised on February 1, 2012
Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
Section 15.231 Periodic operation in the band 40.66 - 40.70MHz and above 70MHz

*The revision on February 1, 2012 does not affect the test specification applied to the EUT.

3.2 Procedures and results

Item	Test Procedure	Specification	Worst margin	Results	Remarks
Conducted emission	FCC: ANSI C63.4:2003 7. AC powerline conducted emission measurements IC: RSS-Gen 7.2.4	FCC: Section 15.207 ----- IC: RSS-Gen 7.2.4	N/A	N/A*1)	-
Automatically Deactivate	FCC: ANSI C63.4:2003 13. Measurement of intentional radiators IC: -	FCC: Section 15.231(a)(1) ----- IC: RSS-210 A1.1.1	N/A	Complied	Radiated
Electric Field Strength of Fundamental Emission	FCC: ANSI C63.4:2003 13. Measurement of intentional radiators IC: RSS-Gen 4.8	FCC: Section 15.231(b) ----- IC: RSS-210 A1.1.2	10.8dB 314.378MHz Horizontal PK with Duty Factor	Complied	Radiated
Electric Field Strength of Spurious Emission	FCC: ANSI C63.4:2003 13. Measurement of intentional radiators IC: RSS-Gen 4.9	FCC: Section 15.205 Section 15.209 Section 15.231(b) ----- IC: RSS-210 A1.1.2, 2.5.1 RSS-Gen 7.2.5	9.2dB 2514.976MHz Horizontal PK with Duty Factor	Complied	Radiated
-20dB Bandwidth	FCC: ANSI C63.4:2003 13. Measurement of intentional radiators IC: -	FCC: Section 15.231(c) ----- IC: Reference data	N/A	Complied	Radiated

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.

*1) The test is not applicable since the EUT does not have AC Mains.

FCC 15.31 (e)

This test was performed with the New Battery (DC 3.0V) and the constant voltage was supplied to the EUT during the tests. Therefore, the EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

UL Japan, Inc.

Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

Facsimile : +81 596 24 8124

3.3 Addition to standard

Item	Test Procedure	Specification	Worst margin	Results	Remarks
99% Occupied Bandwidth	IC: RSS-Gen 4.6.1	IC: RSS-Gen 4.6.1	N/A	Complied	Radiated

Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

EMI

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Test room (semi-anechoic chamber)	Radiated emission						
	(3m*)(+dB)				(1m*)(+dB)		(0.5m*)(+dB)
	9kHz -30MHz	30MHz -300MHz	300MHz -1GHz	1GHz -10GHz	10GHz -18GHz	18GHz -26.5GHz	26.5GHz -40GHz
No.1	4.2dB	5.0dB	5.1dB	5.6dB	5.9dB	4.4dB	4.3dB
No.2	4.1dB	5.2dB	5.1dB	5.7dB	5.8dB	4.3dB	4.2dB
No.3	4.5dB	5.0dB	5.2dB	5.7dB	5.8dB	4.5dB	4.2dB
No.4	4.7dB	5.2dB	5.2dB	5.7dB	5.8dB	5.1dB	4.2dB

*3m/1m/0.5m = Measurement distance

Radiated emission test(3m)

The data listed in this test report has enough margin, more than the site margin.

UL Japan, Inc.

Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

Facsimile : +81 596 24 8124

3.5 Test Location

UL Japan, Inc. Head Office EMC Lab. *NVLAP Lab. code: 200572-0
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN
Telephone : +81 596 24 8116 Facsimile : +81 596 24 8124

	FCC Registration Number	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	313583	2973C-1	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	655103	2973C-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	148738	2973C-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	134570	2973C-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	-	4.0 x 4.5 x 2.7m	4.75 x 5.4 m	-
No.6 measurement room	-	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	-	3.1 x 5.0 x 2.7m	N/A	-
No.9 measurement room	-	-	8.0 x 4.5 x 2.8m	2.0 x 2.0m	-
No.10 measurement room	-	-	2.6 x 2.8 x 2.5m	2.4 x 2.4m	-
No.11 measurement room	-	-	3.1 x 3.4 x 3.0m	2.4 x 3.4m	-

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test set up, Data of EMI, Test instruments.

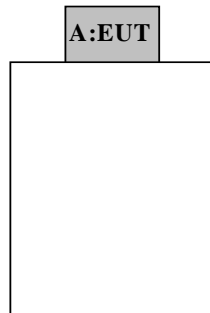
Refer to APPENDIX.

SECTION 4: Operation of E.U.T. during testing

4.1 Operating Modes

Test Item*	Mode
Automatically Deactivate Duty Cycle -20dB & 99% Occupied Bandwidth	Normal use mode
Electric Field Strength of Fundamental Emission Electric Field Strength of Spurious Emission	Transmitting mode (Tx) *1)
* The system was configured in typical fashion (as a customer would normally use it) for testing. *1) The software of this mode is the same as one of normal product, except that EUT continues to transmit when transmitter button is being pressed (For Normal use mode, EUT stops when transmitter button is being pressed.) End users cannot change the settings of the output power of the product.	

4.2 Configuration and peripherals



* Test data was taken under worse case conditions.

Description of EUT

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Remote Keyless Entry System (Transmitter)	12BDP	001 *1) 002 *2)	DENSO CORPORATION	EUT

*1) Used for Transmitting mode

*2) Used for Normal use mode

UL Japan, Inc.

Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

Facsimile : +81 596 24 8124

SECTION 5: Radiated emission (Electric Field Strength of Fundamental and Spurious Emission)

Test Procedure and conditions

EUT was placed on a urethane platform of nominal size, 1.0m by 1.5m, raised 0.8m above the conducting ground plane. The EUT was set on the center of the tabletop. Test was made with the antenna positioned in both the horizontal and vertical planes of polarization. The measurement antenna was varied in height above the conducting ground plane to obtain the maximum signal strength. Photographs of the set up are shown in Appendix 1.

[Transmitting mode]

(Below 30MHz)

The noise level was checked by moving a search-coil (Loop Antenna) close the EUT.

(Above 30MHz)

The Radiated Electric Field Strength has been measured on Semi anechoic chamber with a ground plane and at a distance of 3m.

The measuring antenna height was varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

The measurements were performed for both vertical and horizontal antenna polarization.

The radiated emission measurements were made with the following detector function of the test receiver/spectrum analyzer.

Test Antennas are used as below;

Frequency	Below 30MHz	30MHz to 300MHz	300MHz to 1GHz	Above 1GHz
Antenna Type	Loop	Biconical	Logperiodic	Horn

	Below or equal to 1GHz	Above 1GHz
Detector Type	Peak and Peak with Duty factor	Peak and Peak with Duty factor
IF Bandwidth	120kHz	PK: S/A:RBW 1MHz, VBW:3MHz

- The carrier level (or, noise levels) was (or were) measured at each position of all three axes X, Y and Z, and the position that has the maximum noise was determined. Noise levels of all the frequencies were measured at the position.

*The result is rounded off to the second decimal place, so some differences might be observed.

Measurement range : 30MHz-3.2GHz
Test data : APPENDIX
Test result : Pass

UL Japan, Inc.

Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

Facsimile : +81 596 24 8124

SECTION 6: Automatically deactivate

Test Procedure

The measurement was performed with Electric field strength using a spectrum analyzer.

Test data : APPENDIX
Test result : Pass

SECTION 7: -20dB and 99% Occupied Bandwidth

Test Procedure

The measurement was performed in the antenna height to gain the maximum of Electric field strength.

Test	Span	RBW	VBW	Sweep	Detector	Trace	Instrument used
20dB Bandwidth	1MHz	10kHz	30kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99% Occupied Bandwidth	Enough width to display 20dB Bandwidth	1 % of Span	Three times of RBW	Auto	Peak *1)	Max Hold *1)	Spectrum Analyzer

*1) The measurement was performed with Peak detector, Max Hold since the duty cycle was not 100%.

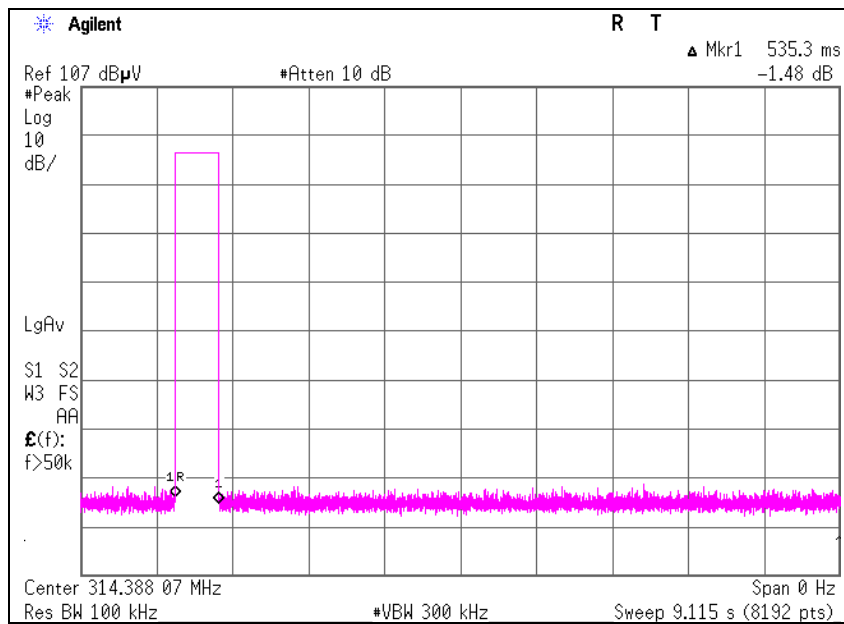
Test data : APPENDIX
Test result : Pass

APPENDIX 1: Data of EMI test

Automatically deactivate

Test place Head Office EMC Lab. No.2 Semi Anechoic Chamber
 Report No. 32BE0281-HO-01
 Date 10/20/2011
 Temperature/ Humidity 24 deg. C/ 52% RH
 Engineer Takeshi Choda
 Mode Normal use mode

Time of Transmitting [sec]	Limit [sec]	Result
0.535	5.00	Pass



Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)

Test place : Head Office EMC Lab. No.2 Semi Anechoic Chamber
Report No. : 32BE0281-HO-01
Date : 10/20/2011
Temperature/ Humidity : 24 deg. C / 52% RH
Engineer : Takeshi Choda
Mode : Transmitting mode

PK

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit dBuV/m	Margin [dB]		Remark Inside or Outside of Restricted Bands
		Hor	Ver					Hor	Ver		Hor	Ver	
314.378	PK	74.9	72.2	14.5	8.9	27.7	-	70.6	67.9	95.5	24.9	27.6	Carrier
628.746	PK	36.3	36.6	19.8	10.3	28.7	-	37.7	38.0	75.5	37.8	37.5	Outside
943.118	PK	31.8	32.6	22.7	11.4	27.7	-	38.2	39.0	75.5	37.3	36.5	Outside
1257.488	PK	44.9	47.2	24.7	1.6	34.0	-	37.2	39.5	75.5	38.3	36.0	Outside
1571.994	PK	45.3	45.0	25.7	1.8	33.2	-	39.6	39.3	73.9	34.3	34.6	Inside
1886.232	PK	47.7	49.8	26.5	2.0	32.6	-	43.6	45.7	75.5	31.9	29.8	Outside
2200.604	PK	53.1	51.6	27.1	2.1	32.3	-	50.0	48.5	73.9	23.9	25.4	Inside
2514.976	PK	54.5	50.8	27.6	2.3	32.2	-	52.2	48.5	75.5	23.3	27.0	Outside
2829.348	PK	48.4	44.5	28.1	2.4	32.0	-	46.9	43.0	73.9	27.0	30.9	Inside
3143.720	PK	44.8	42.5	28.6	2.6	31.9	-	44.1	41.8	75.5	31.4	33.7	Outside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter) - Gain(Amplifier)

PK with Duty factor

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit dBuV/m	Margin [dB]		Remark
		Hor	Ver					Hor	Ver		Hor	Ver	
314.378	PK	74.9	72.2	14.5	8.9	27.7	-5.9	64.7	62.0	75.5	10.8	13.5	Carrier
628.746	PK	36.3	36.6	19.8	10.3	28.7	-5.9	31.8	32.1	55.5	23.7	23.4	Outside
943.118	PK	31.8	32.6	22.7	11.4	27.7	-5.9	32.3	33.1	55.5	23.2	22.4	Outside
1257.488	PK	44.9	47.2	24.7	1.6	34.0	-5.9	31.3	33.6	55.5	24.2	21.9	Outside
1571.994	PK	45.3	45.0	25.7	1.8	33.2	-5.9	33.7	33.4	53.9	20.2	20.5	Inside
1886.232	PK	47.7	49.8	26.5	2.0	32.6	-5.9	37.7	39.8	55.5	17.8	15.7	Outside
2200.604	PK	53.1	51.6	27.1	2.1	32.3	-5.9	44.1	42.6	53.9	9.8	11.3	Inside
2514.976	PK	54.5	50.8	27.6	2.3	32.2	-5.9	46.3	42.6	55.5	9.2	12.9	Outside
2829.348	PK	48.4	44.5	28.1	2.4	32.0	-5.9	41.0	37.1	53.9	12.9	16.8	Inside
3143.720	PK	44.8	42.5	28.6	2.6	31.9	-5.9	38.2	35.9	55.5	17.3	19.6	Outside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter) - Gain(Amplifier) + Duty factor (Refer to Duty factor data sheet)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

*No signal detected at 9kHz - 30MHz.

* The test above 1GHz was performed with PK detect. Average emission measurements were calculated with PK detect and Duty cycle factor.

* Duty Factor was calculated with the assumption of the worst condition in 100msec.

* The noise measured with PK detect was pulse emission.

-20dB and 99% Occupied Bandwidth

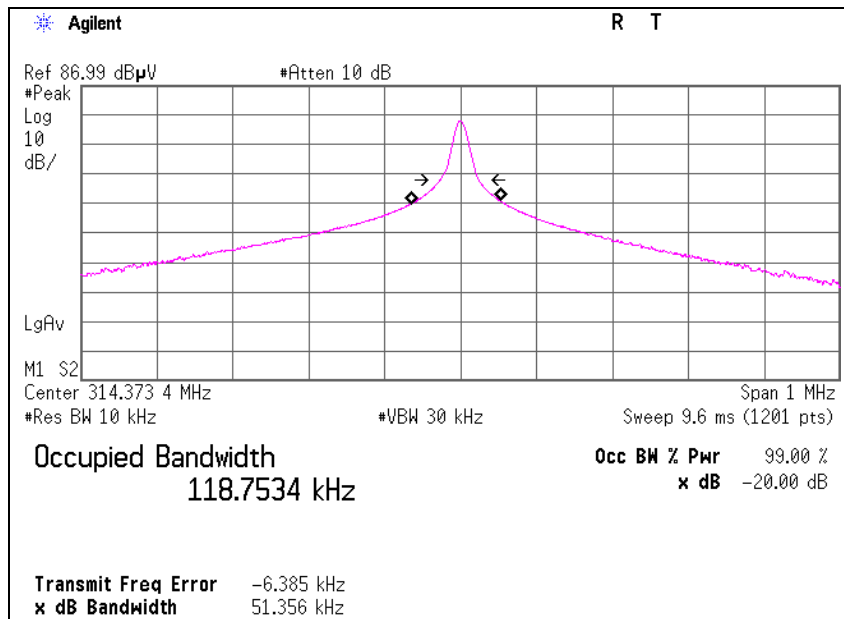
Test place	Head Office EMC Lab. No.2 Semi Anechoic Chamber
Report No.	32BE0281-HO-01
Date	10/20/2011
Temperature/ Humidity	24 deg. C / 52% RH
Engineer	Takeshi Choda
Mode	Normal use mode

Bandwidth Limit : Fundamental Frequency $314.35 \text{ MHz} \times 0.25\% = 785.88 \text{ kHz}$

* The above limit was calculated from more stringent nominal frequency.

-20dB Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
51.36	785.88	Pass

99% Occupied Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
118.75	785.88	Pass



Duty Cycle

Test place Head Office EMC Lab. No.2 Semi Anechoic Chamber
Report No. 32BE0281-HO-01
Date 10/20/2011
Temperature/ Humidity 24 deg. C / 52% RH
Engineer Takeshi Choda
Mode Normal use mode

Type	Times	ON time(One pulse) [ms]	ON time(in 100ms) [ms]
A	55	0.350	19.228
B	45	0.694	31.235

*1)ON time(in 100ms) = Times * ON time(One pulse)

*2)The train of pulses was exceeding 100msec, and that sampled 100msec was the worst case against the pulse train.

(Total)

ON time [ms]	Cycle [ms]	Duty (On time/Cycle)	Duty [dB]
50.463	100.00	0.5046	-5.94

*3)ON time = Type A's ON time (in 100ms) + Type B's ON time (in 100ms)

*4)Duty = $20\log_{10}(\text{ON time}/\text{Cycle})$

*This is a reasonable actual measurement also from specification. Refer to general description.

UL Japan, Inc.

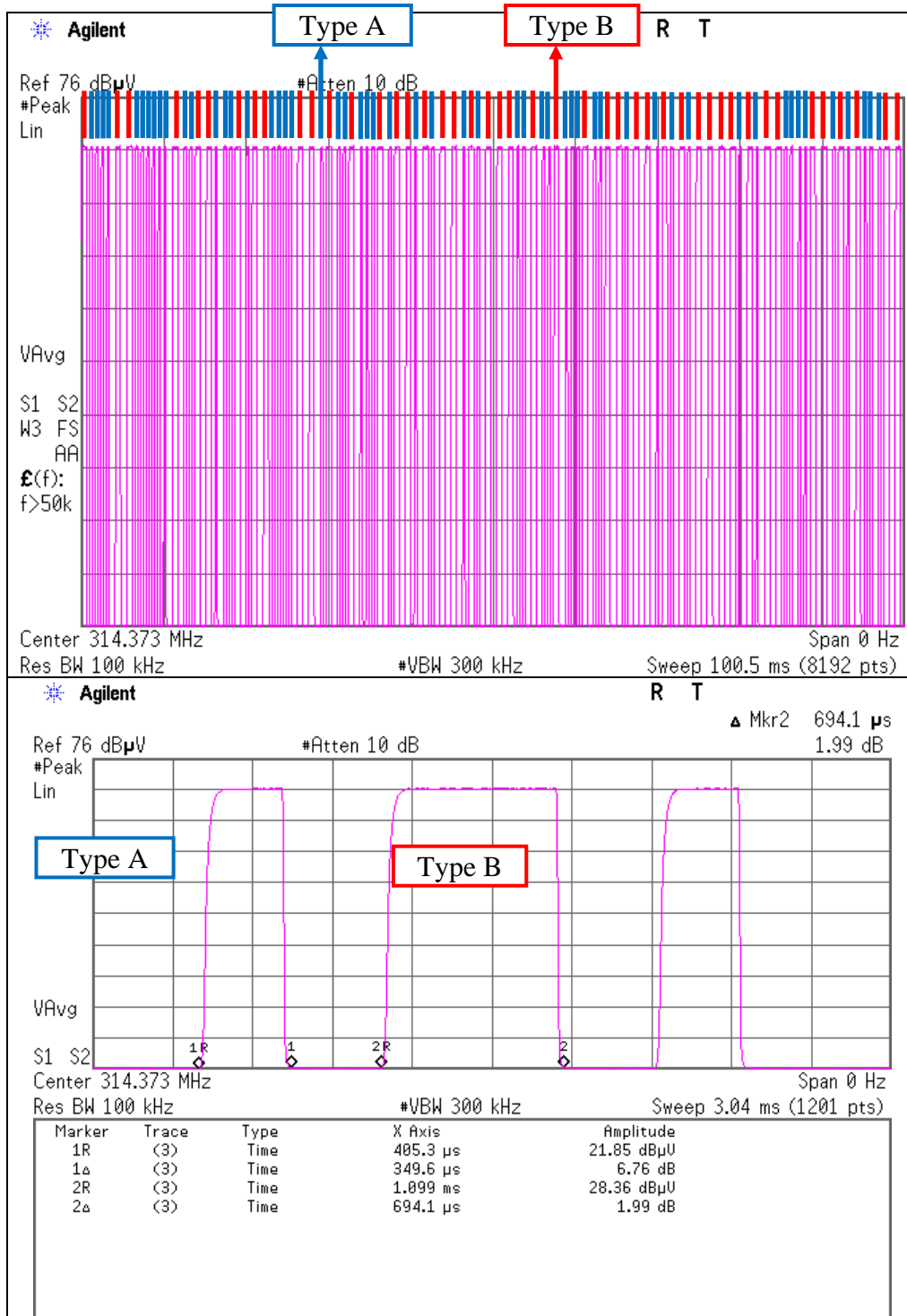
Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

Facsimile : +81 596 24 8124

Duty Cycle



APPENDIX 2:Test Instruments

EMI test equipment

Control No.	Instrument	Manufacturer	Model No	Serial No	Test Item	Calibration Date * Interval(month)
MAEC-02	Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-06902	RE	2011/06/21 * 12
MOS-22	Thermo-Hygrometer	Custom	CTH-201	0003	RE	2011/02/23 * 12
MJM-14	Measure	KOMELON	KMC-36	-	RE	-
COTS-MEMI	EMI measurement program	TSJ	TEPTO-DV	-	RE	-
MSA-04	Spectrum Analyzer	Agilent	E4448A	US44300523	RE	2011/04/08 * 12
MTR-03	Test Receiver	Rohde & Schwarz	ESCI	100300	RE	2011/04/15 * 12
MBA-02	Biconical Antenna	Schwarzbeck	BBA9106	VHA91032008	RE	2011/09/10 * 12
MLA-02	Logperiodic Antenna	Schwarzbeck	USLP9143	201	RE	2011/09/10 * 12
MCC-12	Coaxial Cable	Fujikura/Agilent	-	-	RE	2011/02/18 * 12
MAT-07	Attenuator(6dB)	Weinschel Corp	2	BK7970	RE	2010/11/05 * 12
MPA-09	Pre Amplifier	Agilent	8447D	2944A10845	RE	2011/09/26 * 12
MHA-06	Horn Antenna 1-18GHz	Schwarzbeck	BBHA9120D	254	RE	2011/01/16 * 12
MPA-12	MicroWave System Amplifier	Agilent	83017A	MY39500780	RE	2011/03/10 * 12
MCC-132	Microwave Cable	HUBER+SUHNER	SUCOFLEX104	336161/4(1m) / 340639(5m)	RE	2011/09/06 * 12
MLPA-06	Loop Antenna	UL Japan	-	-	RE	Pre Check

The expiration date of the calibration is the end of the expired month.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

Test Item:

RE: Radiated emission, 99% Occupied Bandwidth, -20dB bandwidth , Automatically deactivate and Duty cycle tests

UL Japan, Inc.

Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

Facsimile : +81 596 24 8124